

## N-Channel and P-Channel 20V(D-S) MOSFET

Product summary			
V <sub>DS</sub>	20	-20	V
R <sub>DS(ON)</sub> (at V <sub>GS</sub> =4.5V) Typ.	8	15.5	mΩ
R <sub>DS(ON)</sub> (at V <sub>GS</sub> =2.5V) Typ.	12	22	mΩ
I <sub>D</sub> (T <sub>C</sub> =25°C)	25	-25	A

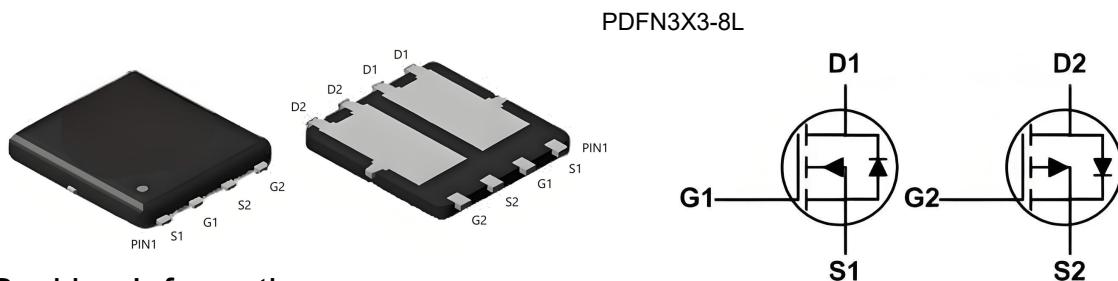
### Features

- Low Gate Charge
- Advanced high cell density Trench technology

### Applications

- Motor driver
- Wireless charging

### Pin Configuration



### Packing Information

Device	Package	Reel Size	Quantity(Min. Package)
ECAL25C02C	PDFN3X3-8L	13 "	5000pcs

### Absolute Maximum Ratings (at T<sub>A</sub>=25°C Unless Otherwise Noted)

Symbol	Parameter	N-Rating	P-Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	20	-20	V
V <sub>GS</sub>	Gate-Source Voltage	±12	±12	V
I <sub>D</sub>	Continuous Drain Current	25	-25	A
		15.8	-15.8	A
I <sub>DM</sub>	Pulse Drain Current Tested <sup>A</sup>	78	69	A
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>B</sup>	36	42	mJ
P <sub>D</sub>	Power Dissipation T <sub>C</sub> =25°C	11	20	W
T <sub>J</sub> , T <sub>STG</sub>	Junction and Storage Temperature Range	-55 to +150	-55 to +150	°C

### Thermal Characteristics

Symbol	Parameter	Typical	Units
R <sub>θJA</sub>	Thermal Resistance-Junction to ambient <sup>C</sup>	30	°C/W
R <sub>θJC</sub>	Thermal Resistance-Junction to case	4	°C/W

N-Channel Electrical Characteristics (at  $T_J = 25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
Static Parameters						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_{\text{D}}=250\mu\text{A}$	20	--	--	V
$\text{I}_{\text{DSS}}$	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=20\text{V}, \text{V}_{\text{GS}}=0\text{V}$	--	--	1	$\mu\text{A}$
$\text{I}_{\text{GSS}}$	Gate-Body Leakage Current	$\text{V}_{\text{DS}}=0\text{V}, \text{V}_{\text{GS}}=\pm 12\text{V}$	--	--	$\pm 100$	nA
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{D}}=250\mu\text{A}$	0.4	0.7	1.0	V
$\text{R}_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance <sup>D</sup>	$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_{\text{D}}=10\text{A}$	--	8	12	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=2.5\text{V}, \text{I}_{\text{D}}=8\text{A}$	--	12	17	$\text{m}\Omega$
$\text{V}_{\text{SD}}$	Diode Forward Voltage	$\text{I}_{\text{S}}=10\text{A}, \text{V}_{\text{GS}}=0\text{V}$	--	--	1.2	V
Dynamic Parameters <sup>E</sup>						
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=10\text{V}$ $f=1\text{MHz}$	--	1010	--	pF
$\text{C}_{\text{oss}}$	Output Capacitance		--	176	--	pF
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance		--	169	--	pF
$\text{Q}_{\text{g}}$	Total Gate Charge	$\text{V}_{\text{DS}}=10\text{V}, \text{I}_{\text{D}}=10\text{A}$ $\text{V}_{\text{GS}}=10\text{V}$	--	28	--	nC
$\text{Q}_{\text{gs}}$	Gate-Source Charge		--	1.9	--	nC
$\text{Q}_{\text{gd}}$	Gate-Drain Charge		--	6.4	--	nC
$t_{\text{D}(\text{on})}$	Turn-on Delay Time	$\text{V}_{\text{DS}}=10\text{V}$ $\text{R}_{\text{L}}=2.5\Omega, \text{I}_{\text{D}}=20\text{A},$ $\text{V}_{\text{GS}}=10\text{V}$	--	13	--	nS
$t_{\text{r}}$	Turn-on Rise Time		--	18	--	nS
$t_{\text{D}(\text{off})}$	Turn-off Delay Time		--	36	--	nS
$t_{\text{f}}$	Turn-off Fall Time		--	16	--	nS

A. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

B. EAS condition:  $T_J=25^\circ\text{C}, V_{DD}=10\text{V}, V_G=4.5\text{V}, RG=25\Omega, L=0.5\text{mH}, I_{AS}=12\text{A}$ .

C. The data tested by surface mounted on a 1 inch x 1 inch FR-4 board with 2OZ copper.

D. Pulse Test: Pulse Width  $\leq 300\text{us}$ , Duty cycle  $\leq 2\%$ .

E. Guaranteed by design, not subject to production testing.

P-Channel Electrical Characteristics (at  $T_J = 25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
Static Parameters						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-20	--	--	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-20\text{V}, V_{\text{GS}}=0\text{V}$	--	--	-1	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=\pm 12\text{V}$	--	--	$\pm 100$	nA
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-0.4	-0.7	-1.0	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance <sup>D</sup>	$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-10\text{A}$	--	15.5	21	$\text{m}\Omega$
		$V_{\text{GS}}=-2.5\text{V}, I_{\text{D}}=-8\text{A}$	--	22	29	$\text{m}\Omega$
$V_{\text{SD}}$	Diode Forward Voltage	$I_{\text{S}}=-10\text{A}, V_{\text{GS}}=0\text{V}$	--	--	-1.2	V
Dynamic Parameters <sup>E</sup>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-10\text{V}$ $f=1\text{MHz}$	--	1610	--	pF
$C_{\text{oss}}$	Output Capacitance		--	230	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	201	--	pF
$Q_g$	Total Gate Charge	$V_{\text{DS}}=-10\text{V}, I_{\text{D}}=-3\text{A}$ $V_{\text{GS}}=-4.5\text{V}$	--	14	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	1.9	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	3.8	--	nC
$t_{\text{D}(\text{on})}$	Turn-on Delay Time	$V_{\text{DS}}=-10\text{V}$ $R_G=4.7\Omega, I_{\text{D}}=-7\text{A}$ , $V_{\text{GS}}=-4.5\text{V}$	--	9	--	nS
$t_r$	Turn-on Rise Time		--	28	--	nS
$t_{\text{D}(\text{off})}$	Turn-off Delay Time		--	27	--	nS
$t_f$	Turn-off Fall Time		--	6	--	nS

A. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

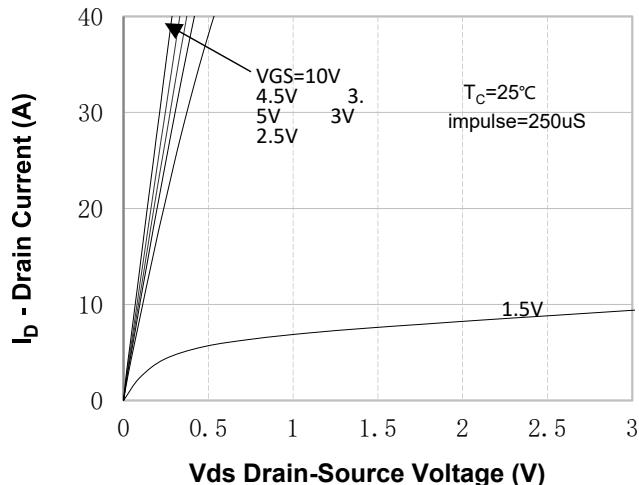
B. EAS condition:  $T_J=25^\circ\text{C}, V_{\text{DD}}=10\text{V}, V_{\text{G}}=4.5\text{V}, R_G=25\Omega, L=0.5\text{mH}, I_{\text{AS}}=13\text{A}$ .

C. The data tested by surface mounted on a 1 inch x 1 inch FR-4 board with 2OZ copper.

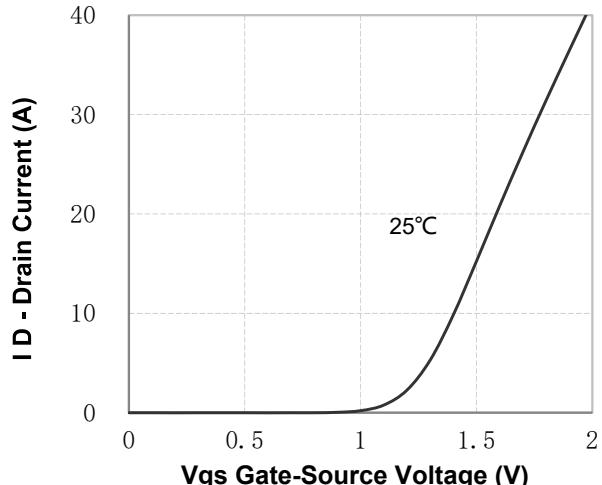
D. Pulse Test: Pulse Width  $\leq 300\text{us}$ , Duty cycle  $\leq 0.5\%$ .

E. Guaranteed by design, not subject to production testing.

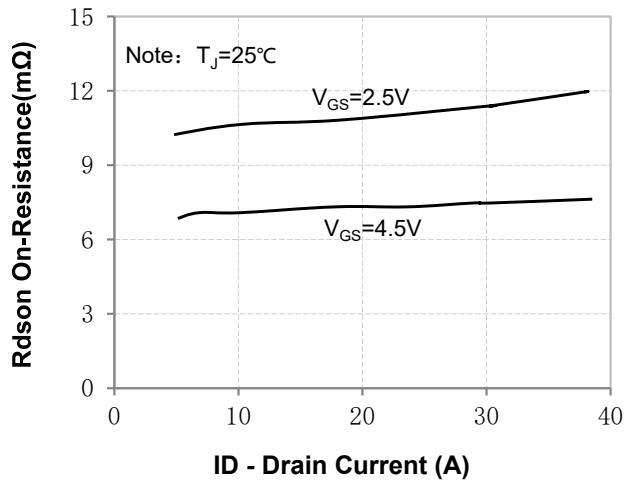
## N-Channel Typical Characteristics



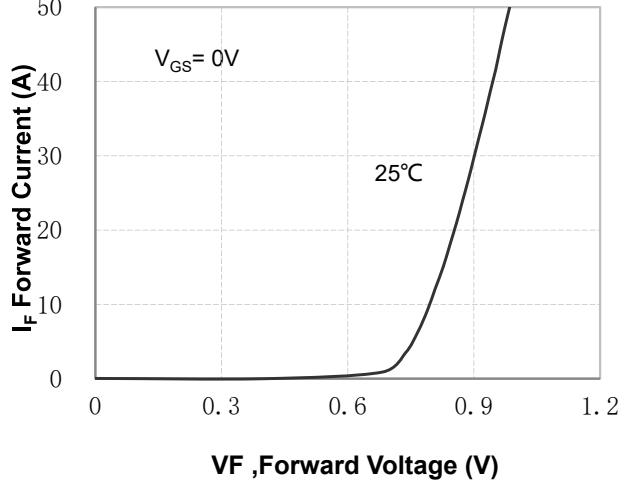
**Figure 1. On-Region Characteristics**



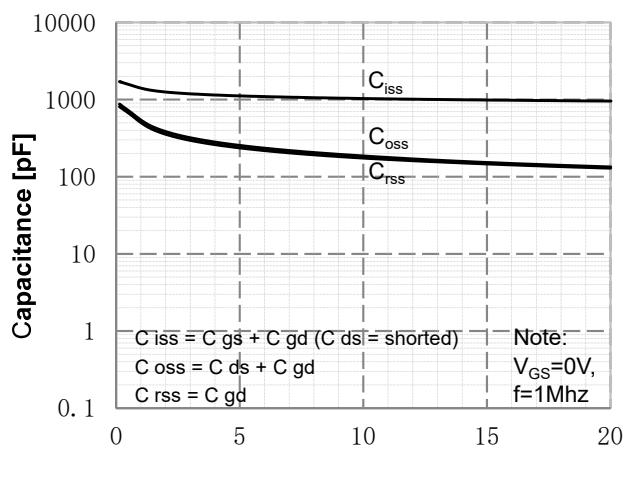
**Figure 2. Transfer Characteristics**



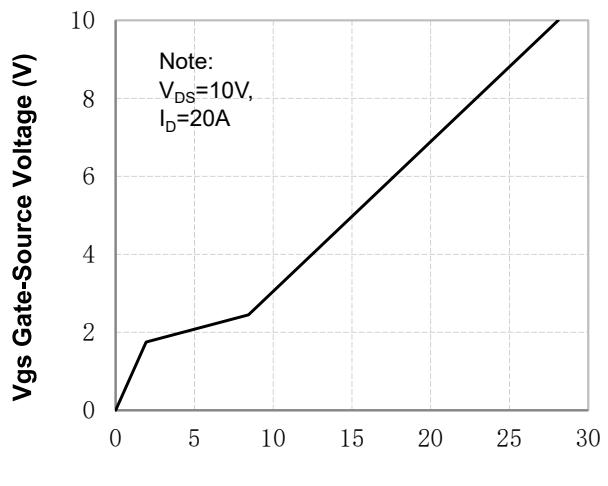
**Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current**

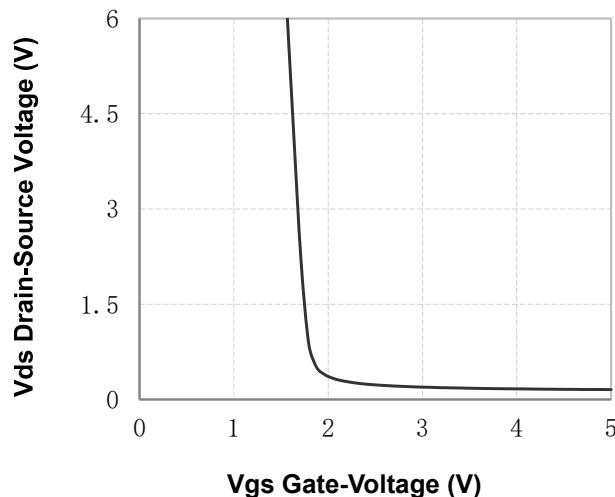


**Figure 5. Capacitance Characteristics**

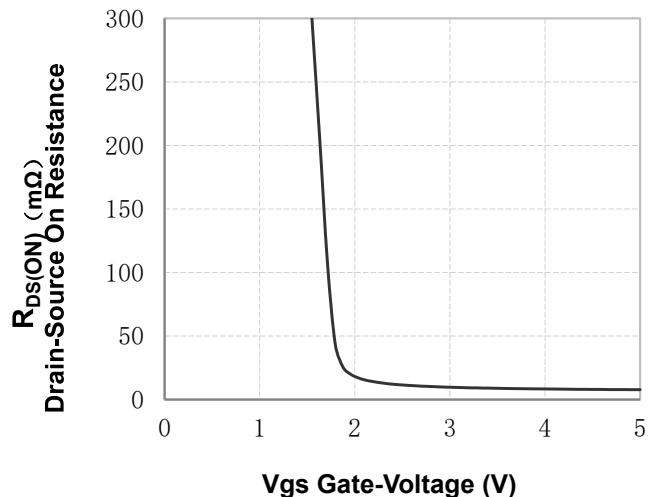


**Figure 6. Gate Charge Characteristics**

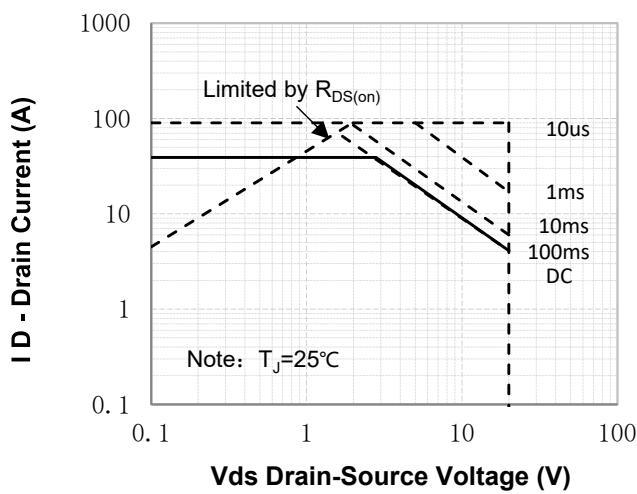
## N-Channel Typical Characteristics



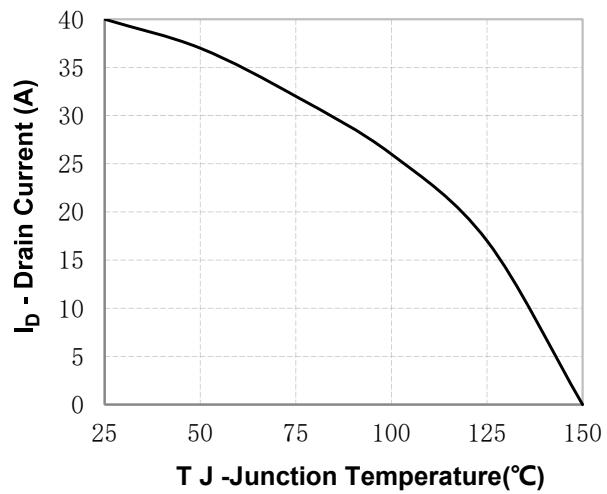
**Figure 7.** V<sub>ds</sub> Drain-Source Voltage vs Gate Voltage



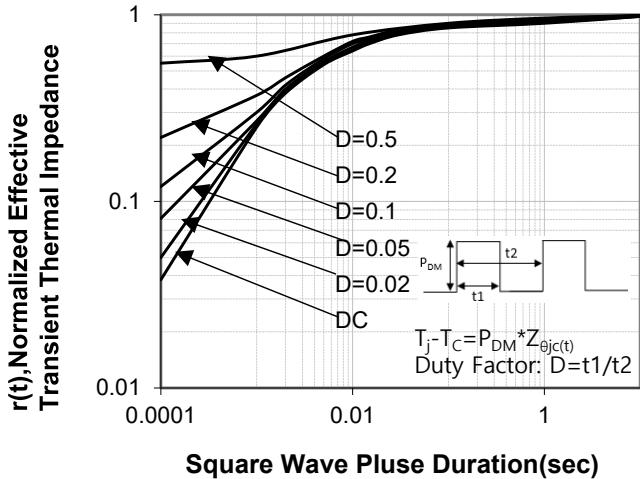
**Figure 8.** On-Resistance vs Gate Voltage



**Figure 9.** Maximum Safe Operating Area

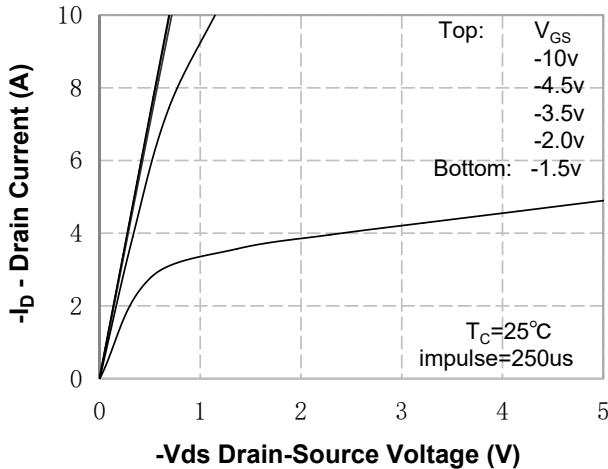


**Figure 10.** Maximum Continuous Drain Current vs Temperature

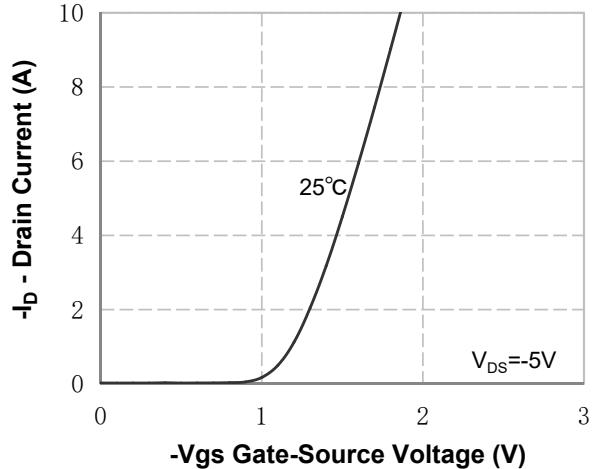


**Figure 11.** Transient Thermal Response Curve

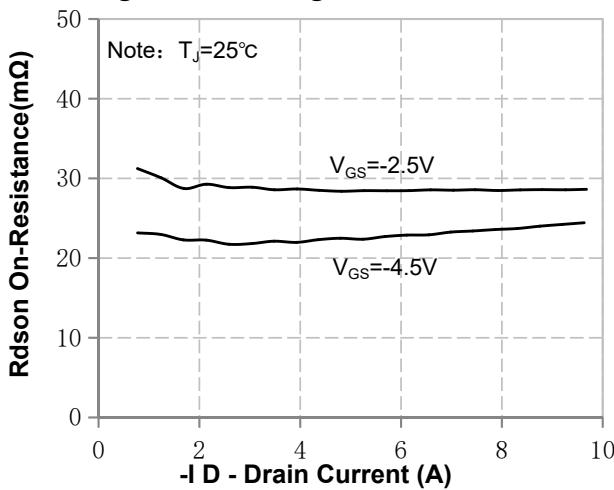
## P-Channel Typical Characteristics



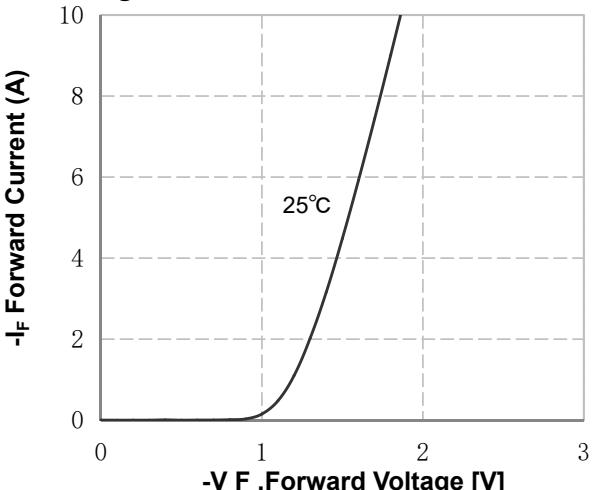
**Figure 1. On-Region Characteristics**



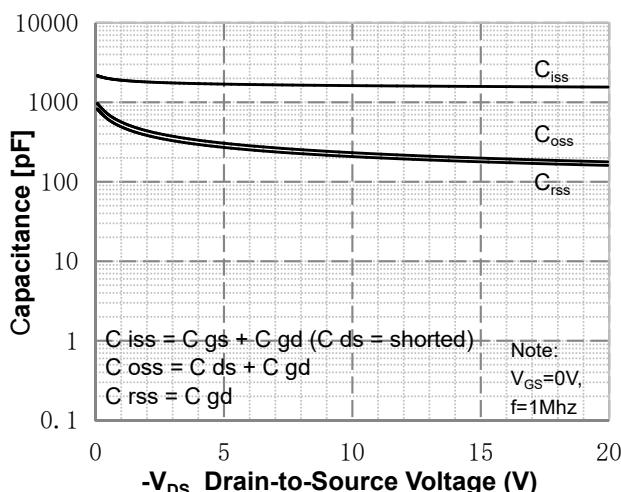
**Figure 2. Transfer Characteristics**



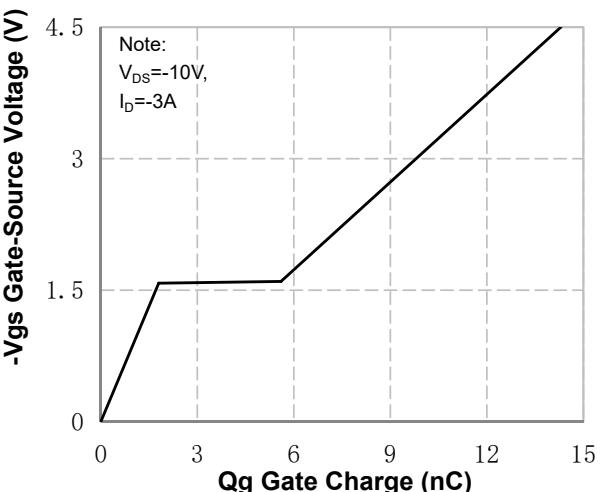
**Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current**

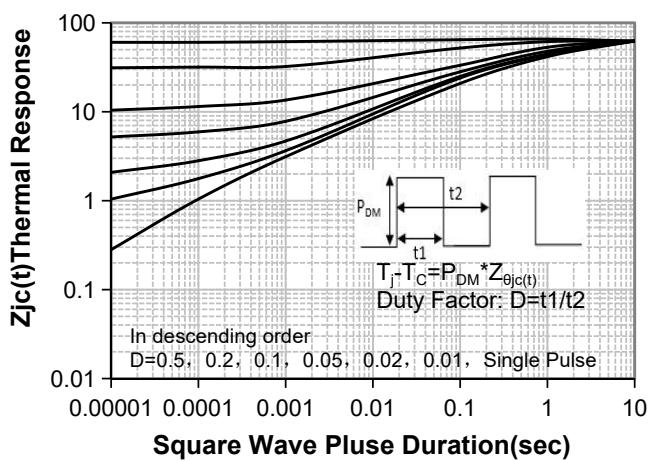
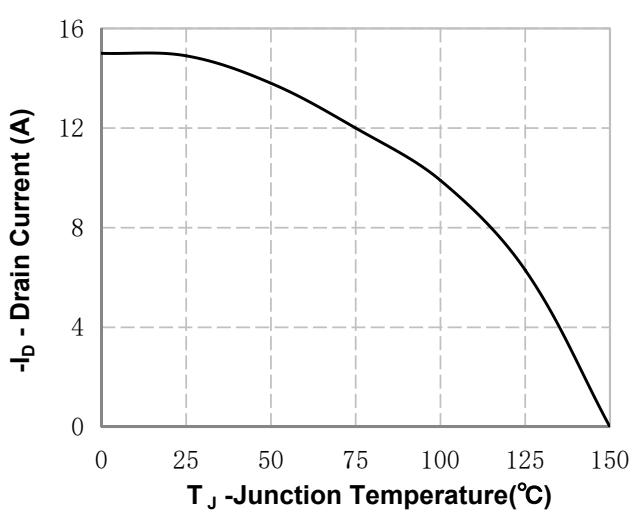
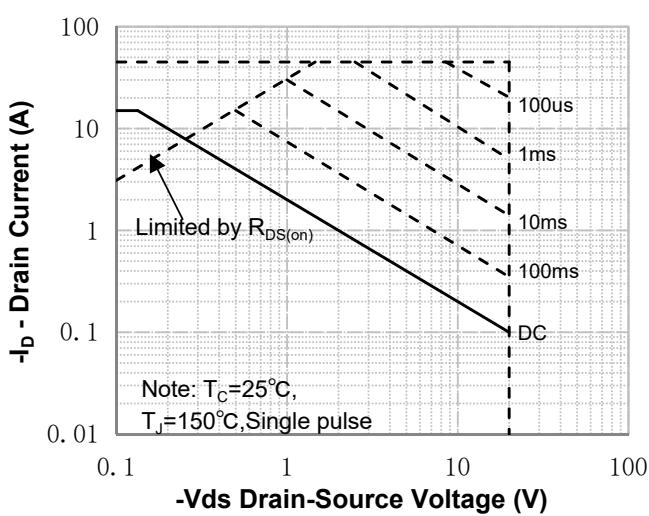
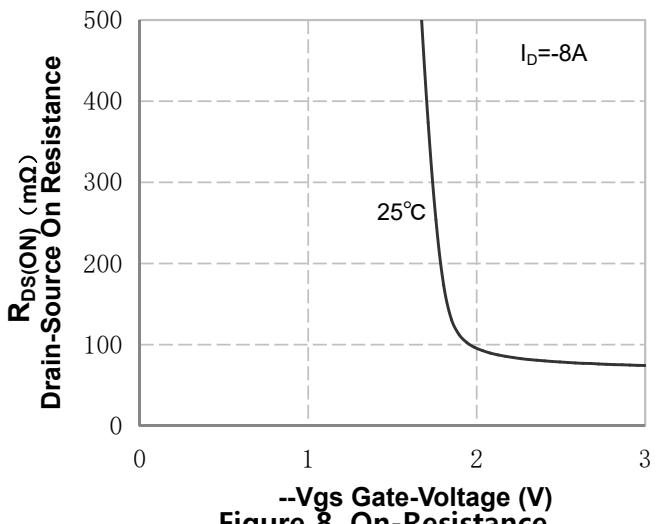
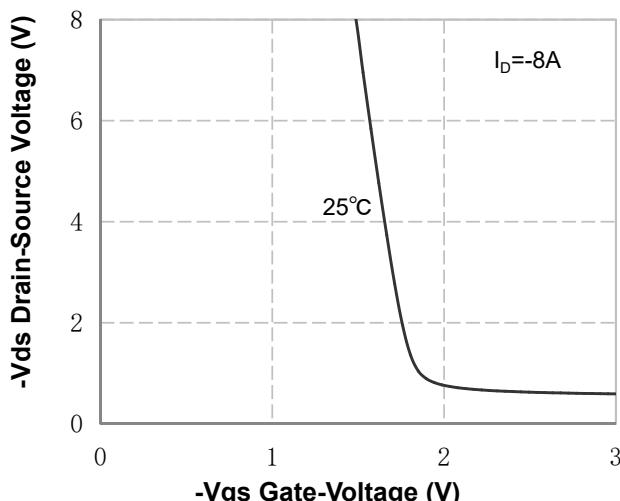


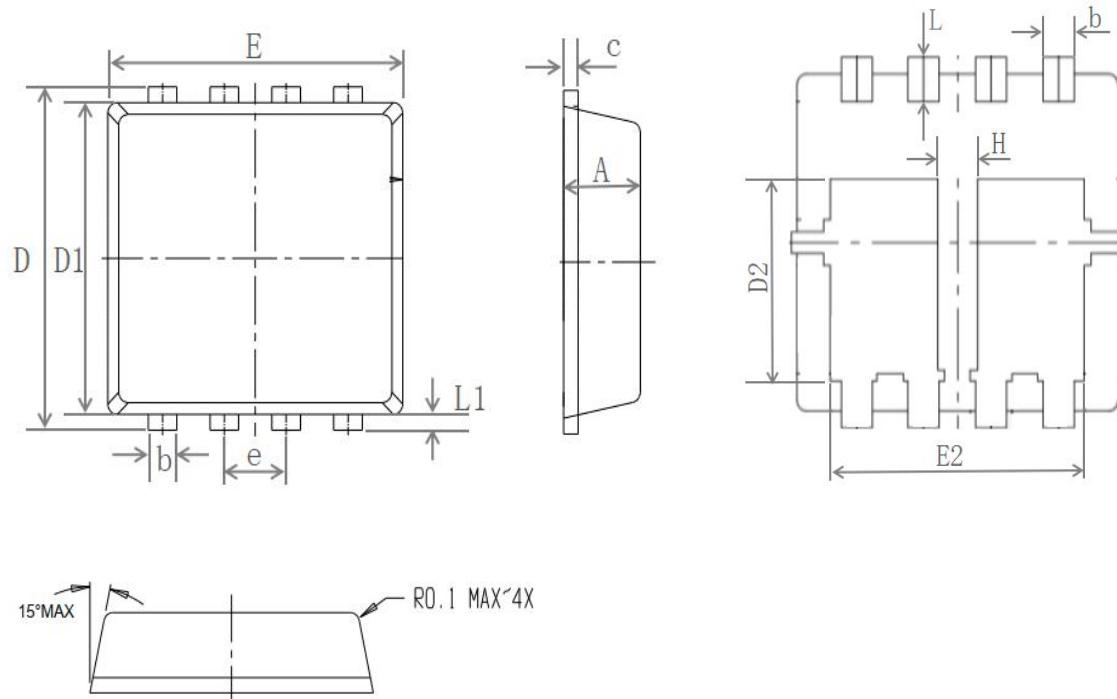
**Figure 5. Capacitance Characteristics**



**Figure 6. Gate Charge Characteristics**

## P-Channel Typical Characteristics



**PDFN3X3-8L Package Information**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.750	0.850	0.295	0.335
b	0.250	0.350	0.098	0.138
c	0.100	0.250	0.039	0.098
D	3.200	3.400	1.260	1.339
D1	2.900	3.100	1.142	1.220
D2	1.635	1.880	0.644	0.740
D3	0.100	0.300	0.039	0.118
E	3.000	3.200	1.181	1.260
E2	2.400	2.600	0.945	1.024
e	0.658REF		0.259REF	
H	0.280	0.480	0.110	0.189
L	0.300	0.500	0.118	0.197
L1	0.100	0.200	0.039	0.079